RoHS

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50 A VRPower® Integrated Power Stage

DESCRIPTION

The SiC632 and SiC632A are integrated power stage solutions optimized for synchronous buck applications to offer high current, high efficiency, and high power density performance. Packaged in Vishay's proprietary 5 mm x 5 mm MLP package, SiC632 and SiC632A enables voltage regulator designs to deliver up to 50 A continuous current per phase.

The internal power MOSFETs utilizes Vishay's state-of-the-art Gen IV TrenchFET® technology that delivers industry benchmark performance to significantly reduce switching and conduction losses.

The SiC632 and SiC632A incorporate an advanced MOSFET gate driver IC that features high current driving capability, adaptive dead-time control, an integrated bootstrap Schottky diode, a thermal warning (THWn) that alerts the system of excessive junction temperature, and zero current detection to improve light load efficiency. The drivers are also compatible with a wide range of PWM controllers and supports tri-state PWM, 3.3 V (SiC632A), 5 V (SiC632) PWM logic.

FEATURES

- Thermally enhanced PowerPAK® MLP55-31L package
- Vishay's Gen IV MOSFET technology and a low side MOSFET with integrated Schottky diode
- Delivers up to 50 A continuous current
- · High efficiency performance
- High frequency operation up to 1.5 MHz
- Power MOSFETs optimized for 19 V input stage
- 3.3 V (SiC632A), 5 V (SiC632) PWM logic with tri-state and hold-off
- Zero current detect control for light load efficiency improvement
- Low PWM propagation delay (< 20 ns)
- Faster disable
- · Thermal monitor flag
- Under voltage lockout for V_{CIN}
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- Multi-phase VRDs for computing, graphics card and memory
- Intel IMVP-8 VRPower delivery
 - V_{CORE} , $V_{GRAPHICS}$, $V_{SYSTEM\ AGENT}$ Skylake, Kabylake platforms
- V_{CCGI} for Apollo Lake platforms
- Up to 24 V rail input DC/DC VR modules

TYPICAL APPLICATION DIAGRAM

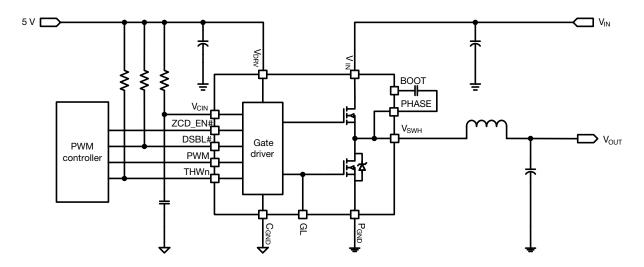


Fig. 1 - SiC632 and SiC632A Typical Application Diagram



PINOUT CONFIGURATION

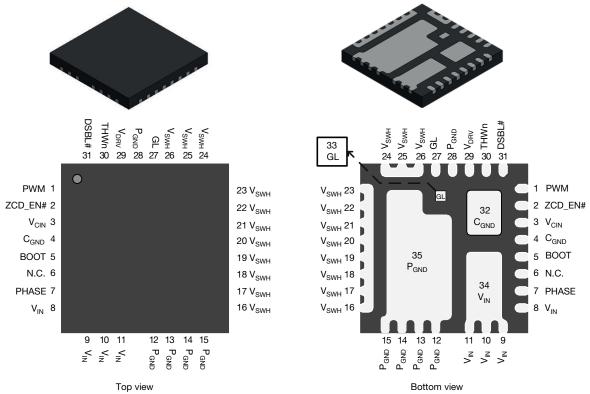


Fig. 2 - SiC632 and SiC632A Pin Configuration

PIN CONFIG	URATION	
PIN NUMBER	NAME	FUNCTION
1	PWM	PWM input logic
2	ZCD_EN#	ZCD control. Active low
3	V _{CIN}	Supply voltage for internal logic circuitry
4, 32	C_{GND}	Signal ground
5	BOOT	High side driver bootstrap voltage
6	N.C.	Not connected internally, can be left floating or connected to ground
7	PHASE	Return path of high side gate driver
8 to 11, 34	V _{IN}	Power stage input voltage. Drain of high side MOSFET
12 to 15, 28, 35	P_{GND}	Power ground
16 to 26	V _{SWH}	Phase node of the power stage
27, 33	GL	Low side MOSFET gate signal
29	V_{DRV}	Supply voltage for internal gate driver
30	THWn	Thermal warning open drain output
31	DSBL#	Disable pin. Active low

ORDERING INFORMATION						
PART NUMBER	PACKAGE	MARKING CODE	OPTION			
SiC632CD-T1-GE3	PowerPAK MLP55-31L	SiC632	5 V PWM optimized			
SiC632ACD-T1-GE3	PowerPAK MLP55-31L	SiC632A	3.3 V PWM optimized			
SiC632DB / SiC632ADB		Reference board				





PART MARKING INFORMATION

P/N
LL \(\triangle \)
FYWW

= Pin 1 Indicator

P/N = Part Number Code

= Siliconix Logo

 \triangle = ESD Symbol

F = Assembly Factory Code

Y = Year Code

WW = Week Code

LL = Lot Code

ELECTRICAL PARAMETER	CONDITIONS	LIMIT	UNIT
Input voltage	V _{IN}	-0.3 to +28	
Control logic supply voltage	V _{CIN}	-0.3 to +7	
Drive supply voltage	V _{DRV}	-0.3 to +7	
Switch node (DC voltage)	V	-0.3 to +28	
Switch node (AC voltage) (1)	V _{swн}	-7 to +33	
BOOT voltage (DC voltage)	V	35	V
BOOT voltage (AC voltage) (2)	V _{BOOT}	40	
BOOT to PHASE (DC voltage)		-0.3 to +7	
BOOT to PHASE (AC voltage) (3)	V _{BOOT-PHASE}	-0.3 to +8	
All logic inputs and outputs (PWM, DSBL#, and THWn)		-0.3 to V _{CIN} + 0.3	
Max. operating junction temperature	T _J	150	
Ambient temperature	T _A	-40 to +125	°C
Storage temperature	T _{stg}	-65 to +150	
Floring the discharge protection	Human body model, JESD22-A114	3000	
Electrostatic discharge protection	Charged device model, JESD22-C101	1000	V

Notes

 $^{^{(3)}}$ The specification value indicates "AC voltage" is V_{BOOT} to V_{PHASE} , 8 V (< 20 ns) max.

RECOMMENDED OPERATING RANGE						
ELECTRICAL PARAMETER	MINIMUM	TYPICAL	MAXIMUM	UNIT		
Input voltage (V _{IN})	4.5	-	24			
Drive supply voltage (V _{DRV})	4.5	5	5.5	V		
Control logic supply voltage (V _{CIN})	4.5	5	5.5	v		
BOOT to PHASE (V _{BOOT-PHASE} , DC voltage)	4	4.5	5.5			
Thermal resistance from junction to ambient	-	10.6	-	°C/W		
Thermal resistance from junction to case	-	1.6	-	C/VV		

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings
only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the
specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability

⁽¹⁾ The specification values indicated "AC" is V_{SWH} to P_{GND} -8 V (< 20 ns, 10 μJ), min. and 33 V (< 50 ns), max.

⁽²⁾ The specification value indicates "AC voltage" is V_{BOOT} to P_{GND}, 40 V (< 50 ns) max.

DADAMETED	CVMDOL	TEST CONDITION	LIMITS			11111
PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
POWER SUPPLY						
		$V_{DSBL\#} = 0 V$, no switching, $V_{PWM} = FLOAT$	-	10	-	
Control logic supply current	I _{VCIN}	$V_{DSBL\#} = 5 \text{ V}$, no switching, $V_{PWM} = FLOAT$	-	300	-	μΑ
		$V_{DSBL\#} = 5 \text{ V}, f_S = 300 \text{ kHz}, D = 0.1$	-	525	-	
		$f_S = 300 \text{ kHz}, D = 0.1$	-	10	15	mA
Drive supply current	I _{VDRV}	f _S = 1 MHz, D = 0.1	-	35	-	1117 (
Brive supply surrent	'VDRV	$V_{DSBL\#} = 0 V$, no switching	-	15	-	μΑ
		$V_{DSBL\#} = 5 V$, no switching	-	55	-	μ, ι
BOOTSTRAP SUPPLY				ı	I	
Bootstrap diode forward voltage	V_{F}	$I_F = 2 \text{ mA}$			0.4	V
PWM CONTROL INPUT (SiC632)					1 .	1
Rising threshold	V _{TH_PWM_R}		3.4	3.8	4.2	
Falling threshold	$V_{TH_PWM_F}$		0.72	0.9	1.1	
Tri-state voltage	V_{TRI}	V _{PWM} = FLOAT	-	2.3	-	V
Tri-state rising threshold	$V_{TRI_TH_R}$		0.9	1.15	1.38	
Tri-state falling threshold	$V_{TRI_TH_F}$		3	3.3	3.6	
Tri-state rising threshold hysteresis	V _{HYS_TRI_R}		-	225	-	mV
Tri-state falling threshold hysteresis	$V_{HYS_TRI_F}$		-	325	-	
PWM input current	I _{PWM}	V _{PWM} = 5 V	-	-	350	μΑ
·	·FVVIVI	$V_{PWM} = 0 V$	-	-	-350	ļ
PWM CONTROL INPUT (SiC632A)				T	ı	
Rising threshold	$V_{TH_PWM_R}$		2.3	2.45	2.7	
Falling threshold	$V_{TH_PWM_F}$		0.72	0.9	1.1	
Tri-state Voltage	V_{TRI}	V _{PWM} = FLOAT	-	1.8	-	V
Tri-state rising threshold	$V_{TRI_TH_R}$		0.9	1.15	1.38	
Tri-state falling threshold	$V_{TRI_TH_F}$		1.95	2.2	2.45	
Tri-state rising threshold hysteresis	V _{HYS_TRI_R}		-	250	-	mV
Tri-state falling threshold hysteresis	V _{HYS_TRI_F}		-	300	-	
PWM input current	I _{PWM}	V _{PWM} = 3.3 V	-	-	225	μΑ
·	·FVVIVI	$V_{PWM} = 0 V$	-	-	-225	μ, τ
TIMING SPECIFICATIONS				T	1	
Tri-state to GH/GL rising propagation delay	t _{PD_TRI_R}		-	30	-	
Tri-state hold-off time	t _{TSHO}		-	130	-	
GH - turn off propagation delay	t _{PD_OFF_GH}		-	15	-	
GH - turn on propagation delay (dead time rising)	t _{PD_ON_GH}	No load, see Fig. 4	-	10	-	
GL - turn off propagation delay	t _{PD_OFF_GL}		-	13	-	ns
GL - turn on propagation delay (dead time falling)	t _{PD_ON_GL}		-	10	-	
DSBL# Lo to GH/GL falling propagation delay	t _{PD_DSBL#_F}	Fig. 5	-	15	-	
PWM minimum on-time	t _{PWM_ON_MIN}		30	-	_	

ELECTRICAL SPECIFICA (DSBL# = ZCD_EN# = 5 V, V		$_{RV}$ and V_{CIN} = 5 V, T_A = 25 °C)					
PARAMETER	SYMBOL	OVAROL TEST CONDITION	LIMITS			LINUT	
PARAMETER	STWIBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT	
DSBL# ZCD_EN# INPUT							
DSBL# logic input voltage	V _{IH_DSBL#}	Input logic high	2	-	-		
DSBL# logic input voltage	$V_{IL_DSBL\#}$	Input logic low	-	-	0.8	V	
ZCD_EN# logic input voltage	V _{IH_ZCD_EN#}	Input logic high	2	-	-	V	
ZCD_EN# logic input voltage	V _{IL_ZCD_EN#}	Input logic low	-	-	0.8		
PROTECTION							
Under voltage lockout	V	V _{CIN} rising, on threshold	-	3.7	4.1	V	
Officer voltage lockout	V _{UVLO}	V _{CIN} falling, off threshold	2.7	3.1	-	V	
Under voltage lockout hysteresis	V _{UVLO_HYST}		-	575	=	mV	
THWn flag set (2)	T _{THWn_SET}		-	160	-		
THWn flag clear (2)	T _{THWn_CLEAR}		-	135	-	°C	
THWn flag hysteresis (2)	T _{THWn_HYST}		-	25	-		
THWn output low	V_{OL_THWn}	I _{THWn} = 2 mA	-	0.02	-	V	

Notes

DETAILED OPERATIONAL DESCRIPTION

PWM Input with Tri-State Function

The PWM input receives the PWM control signal from the VR controller IC. The PWM input is designed to be compatible with standard controllers using two state logic (H and L) and advanced controllers that incorporate tri-state logic (H, L and tri-state) on the PWM output. For two state logic, the PWM input operates as follows. When PWM is driven above V_{PWM TH R} the low side is turned off and the high side is turned on. When PWM input is driven below V_{PWM TH F} the high side is turned off and the low side is turned on. For tri-state logic, the PWM input operates as previously stated for driving the MOSFETs when PWM is logic high and logic low. However, there is a third state that is entered as the PWM output of tri-state compatible controller enters its high impedance state during shutdown. The high impedance state of the controller's PWM output allows the SiC632 and SiC632A to pull the PWM input into the tri-state region (see definition of PWM logic and tri-state, Fig. 4). If the PWM input stays in this region for the tri-state hold-off period, tTSHO, both high side and low side MOSFETs are turned off. The function allows the VR phase to be disabled without negative output voltage swing caused by inductor ringing and saves a Schottky diode clamp. The PWM and tri-state regions are separated by hysteresis to prevent false triggering. The SiC632A incorporates PWM voltage thresholds that are compatible with 3.3 V logic and the SiC632 thresholds are compatible with 5 V logic.

Disable (DSBL#)

In the low state, the DSBL# pin shuts down the driver IC and disables both high side and low side MOSFETs. In this state, standby current is minimized. If DSBL# is left unconnected, an internal pull-down resistor will pull the pin to $C_{\mbox{\footnotesize GND}}$ and shut down the IC.

Diode Emulation Mode (ZCD_EN#)

When ZCD_EN# pin is driven below $V_{IL_ZCD_EN\#}$. diode emulation mode is enabled. If the PWM signal switches below $V_{TH_PWM_F}$ then the LS MOSFET is under control of the ZCD (zero crossing detect) comparator. If, after the internal blanking delay, the inductor current becomes less than or = 0 the low side is turned off. Light load efficiency is improved by avoiding discharge of output capacitors. If both high side and low side MOSFETs are required to be turned off, regardless of inductor current, the PWM input should be tri-stated.

Thermal Shutdown Warning (THWn)

The THWn pin is an open drain signal that flags the presence of excessive junction temperature. Connect with a maximum of $20~\text{k}\Omega$, to $\text{V}_{\text{CIN}}.$ An internal temperature sensor detects the junction temperature. The temperature threshold is 160 °C. When this junction temperature is exceeded the THWn flag is set. When the junction temperature drops below 135 °C the device will clear the THWn signal. The SiC632 and SiC632A do not stop operation when the flag is set. The decision to shutdown must be made by an external thermal control function.

Voltage Input (V_{IN})

This is the power input to the drain of the high side power MOSFET. This pin is connected to the high power intermediate BUS rail.

⁽¹⁾ Typical limits are established by characterization and are not production tested

⁽²⁾ Guaranteed by design

Switch Node (V_{SWH} and PHASE)

The switch node, V_{SWH} , is the circuit power stage output. This is the output applied to the power inductor and output filter to deliver the output for the buck converter. The PHASE pin is internally connected to the switch node V_{SWH} . This pin is to be used exclusively as the return pin for the BOOT capacitor. A 20 k Ω resistor is connected between GH (the high side gate) and PHASE to provide a discharge path for the HS MOSFET in the event that V_{CIN} goes to zero while V_{IN} is still applied.

Ground Connections (C_{GND} and P_{GND})

 P_{GND} (power ground) should be externally connected to C_{GND} (signal ground). The layout of the printed circuit board should be such that the inductance separating C_{GND} and P_{GND} is minimized. Transient differences due to inductance effects between these two pins should not exceed 0.5 V

Control and Drive Supply Voltage Input (VDRV, VCIN)

 V_{CIN} is the bias supply for the gate drive control IC. V_{DRV} is the bias supply for the gate drivers. It is recommended to separate these pins through a resistor. This creates a low pass filtering effect to avoid coupling of high frequency gate drive noise into the IC.

Bootstrap Circuit (BOOT)

The internal bootstrap diode and an external bootstrap capacitor form a charge pump that supplies voltage to the BOOT pin. An integrated bootstrap diode is incorporated so that only an external capacitor is necessary to complete the bootstrap circuit. Connect a boot strap capacitor with one leg tied to BOOT pin and the other tied to PHASE pin.

Shoot-Through Protection and Adaptive Dead Time

The SiC632 and SiC632A have an internal adaptive logic to avoid shoot through and optimize dead time. The shoot through protection ensures that both high side and low side MOSFETs are not turned on at the same time. The adaptive dead time control operates as follows. The high side and low side gate voltages are monitored to prevent the MOSFET turning on from tuning on until the other MOSFET's gate voltage is sufficiently low (< 1 V). Built in delays also ensure that one power MOSFET is completely off, before the other can be turned ON. This feature helps to adjust dead time as gate transitions change with respect to output current and temperature.

Under Voltage Lockout (UVLO)

During the start up cycle, the UVLO disables the gate drive holding high side and low side MOSFET gates low until the supply voltage rail has reached a point at which the logic circuitry can be safely activated. The SiC632, SiC632A also incorporates logic to clamp the gate drive signals to zero when the UVLO falling edge triggers the shutdown of the device. As an added precaution, a 20 k Ω resistor is connected between GH (the high side gate) and PHASE to provide a discharge path for the HS MOSFET.

FUNCTIONAL BLOCK DIAGRAM

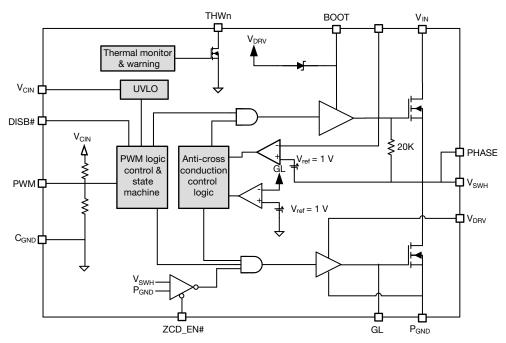


Fig. 3 - SiC632 and SiC632A Functional Block Diagram



DEVICE TRUTH T	DEVICE TRUTH TABLE							
DSBL#	ZCD_EN#	PWM	GH	GL				
Open	Х	Х	L	L				
L	X	X	L	L				
Н	L	L	L	H, I _L > 0 A L, I _L < 0 A				
Н	L	Н	Н	L				
Н	L	Tri-state	L	L				
Н	Н	L	L	Н				
Н	Н	Н	Н	L				
Н	Н	Tri-state	L	L				

PWM TIMING DIAGRAM

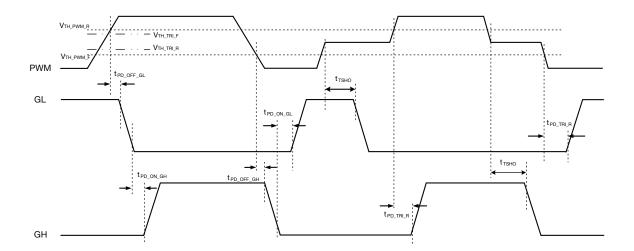


Fig. 4 - Definition of PWM Logic and Tri-state

DSBL# PROPAGATION DELAY

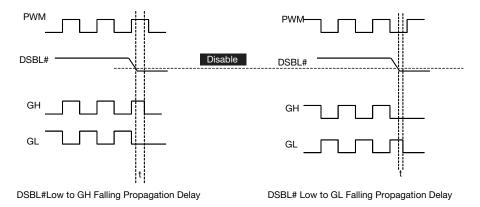


Fig. 5 - DSBL# Falling Propagation Delay



ELECTRICAL CHARACTERISTICS

Test condition: $V_{IN} = 13 \text{ V}$, DSBL# = $V_{DRV} = V_{CIN} = 5 \text{ V}$, ZCD_EN# = 5 V, $V_{OUT} = 1 \text{ V}$, $V_{OUT} = 250 \text{ nH}$ (DCR = 0.32 m Ω), $V_{A} = 25 \text{ °C}$, natural convection cooling (All power loss and normalized power loss curves show SiC632 and SiC632A losses only unless otherwise stated)

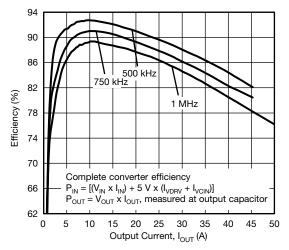


Fig. 6 - Efficiency vs. Output Current (V_{IN} = 12.6 V)

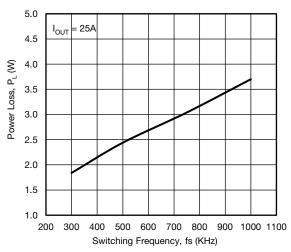


Fig. 7 - Power Loss vs. Switching Frequency (V_{IN} = 12.6 V)

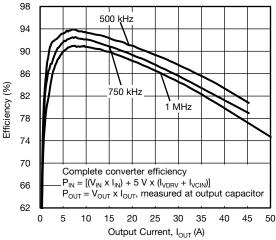


Fig. 8 - Efficiency vs. Output Current (V_{IN} = 9 V)

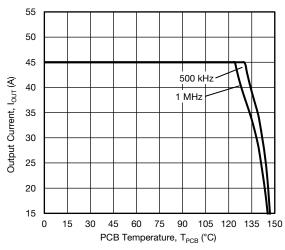


Fig. 9 - Safe Operating Area

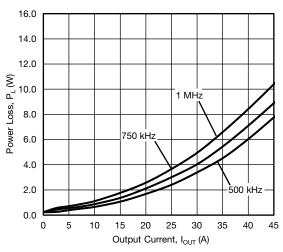


Fig. 10 - Power Loss vs. Output Current (V_{IN} = 12.6 V)

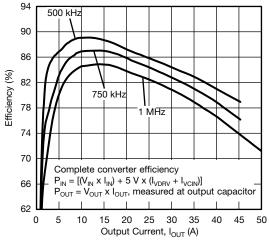


Fig. 11 - Efficiency vs. Output Current (V_{IN} = 19 V)



ELECTRICAL CHARACTERISTICS

Test condition: $V_{IN} = 13 \text{ V}$, DSBL# = $V_{DRV} = V_{CIN} = 5 \text{ V}$, ZCD_EN# = 5 V, $V_{OUT} = 1 \text{ V}$, $V_{OUT} = 250 \text{ nH}$ (DCR = 0.32 m Ω), $V_{A} = 25 \text{ C}$, natural convection cooling (All power loss and normalized power loss curves show SiC632 and SiC632A losses only unless otherwise stated)

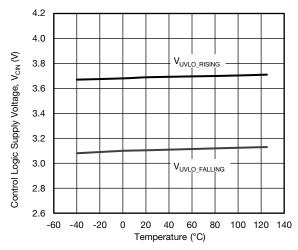


Fig. 12 - UVLO Threshold vs. Temperature

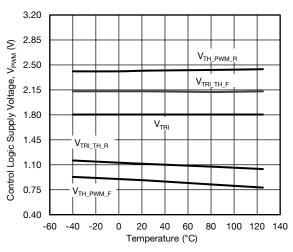


Fig. 13 - PWM Threshold vs. Temperature (SiC632A)

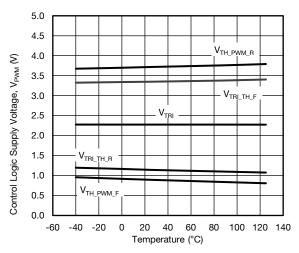


Fig. 14 - PWM Threshold vs. Temperature (SiC632)

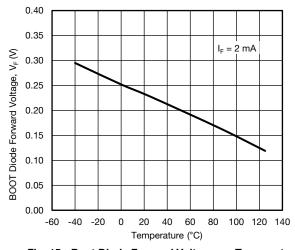


Fig. 15 - Boot Diode Forward Voltage vs. Temperature

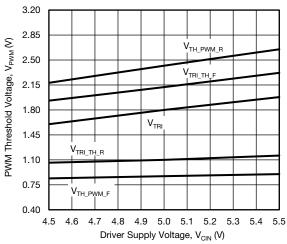


Fig. 16 - PWM Threshold vs. Driver Supply Voltage (SiC632A)

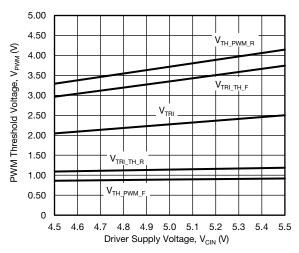


Fig. 17 - PWM Threshold vs. Driver Supply Voltage (SiC632)



ELECTRICAL CHARACTERISTICS

Test condition: $V_{IN} = 13 \text{ V}$, DSBL# = $V_{DRV} = V_{CIN} = 5 \text{ V}$, ZCD_EN# = 5 V, $V_{OUT} = 1 \text{ V}$, $L_{OUT} = 250 \text{ nH}$ (DCR = 0.32 m Ω), $T_A = 25 ^{\circ}$ C, natural convection cooling (All power loss and normalized power loss curves show SiC632 and SiC632A losses only unless otherwise stated)

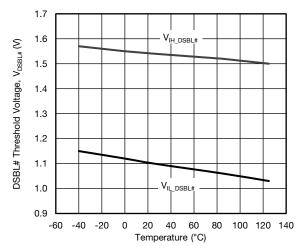


Fig. 18 - DSBL# Threshold vs. Temperature

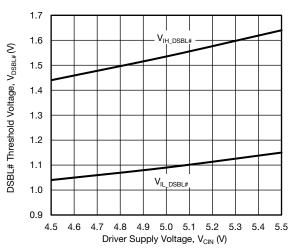


Fig. 19 - DSBL# vs. Driver Input Voltage

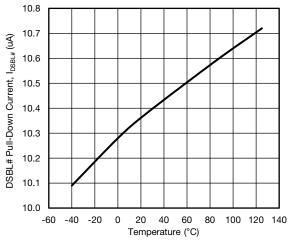


Fig. 20 - DSBL# Pull-Down Current vs. Temperature

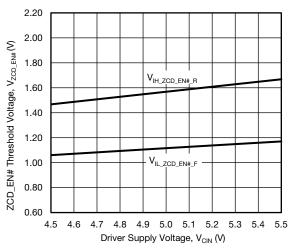


Fig. 21 - ZCD_EN# Threshold vs. Driver Supply Voltage

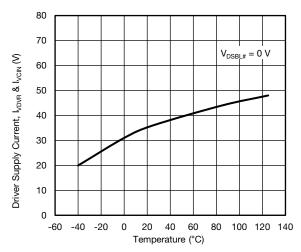


Fig. 22 - Driver Shutdown Current vs. Temperature

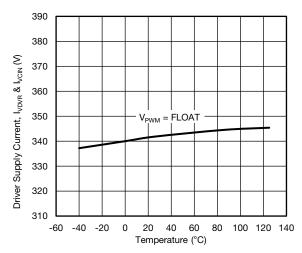
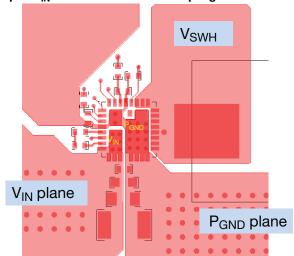


Fig. 23 - Driver Supply Current vs. Temperature



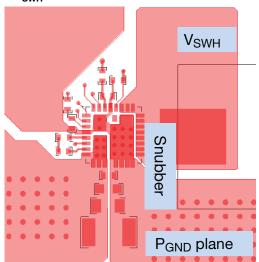
PCB LAYOUT RECOMMENDATIONS

Step 1: V_{IN}/GND Planes and Decoupling



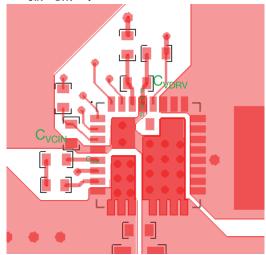
- 1. Layout V_{IN} and P_{GND} planes as shown above
- 2. Ceramic capacitors should be placed right between V_{IN} and P_{GND} , and very close to the device for best decoupling effect
- Difference values / packages of ceramic capacitors should be used to cover entire decoupling spectrum e.g. 1210, 0805, 0603, and 0402
- 4. Smaller capacitance value, closer to device V_{IN} pin(s) better high frequency noise absorbing

Step 2: V_{SWH} Plane



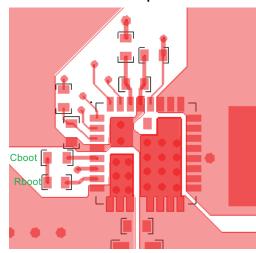
- 1. Connect output inductor to DrMOS with large plane to lower the resistance
- If any snubber network is required, place the components as shown above and the network can be placed at bottom

Step 3: V_{CIN}/V_{DRV} Input Filter



- The V_{CIN}/V_{DRV} input filter ceramic cap should be placed very close to IC. It is recommended to connect two caps separately
- C_{VCIN} cap should be placed between pin 3 and pin 4 (C_{GND} of driver IC) to achieve best noise filtering
- 3. C_{VDRV} cap should be placed between pin 28 (P_{GND} of driver IC) and pin 29 to provide maximum instantaneous driver current for low side MOSFET during switching cycle
- 4. For connecting C_{VCIN} analog ground, it is recommended to use large plane to reduce parasitic inductance

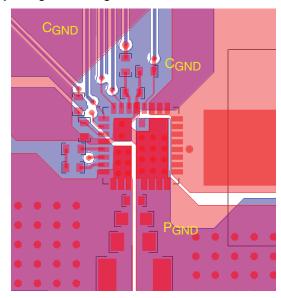
Step 4: BOOT Resistor and Capacitor Placement



- These components need to be placed very close to IC, right between PHASE (pin 7) and BOOT (pin 5)
- 2. To reduce parasitic inductance, chip size 0402 can be used

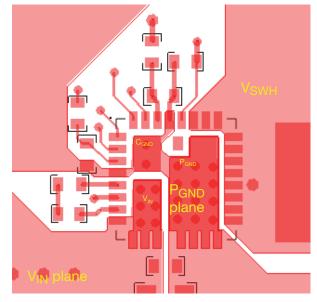


Step 5: Signal Routing



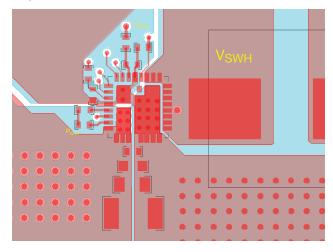
- 1. Route the PWM / ZCD_EN# / DSBL# / THWn signal traces out of the top left corner next DrMOS pin 1
- PWM signal is very important signal, both signal and return traces need to pay special attention of not letting this trace cross any power nodes on any layer
- 3. It is best to "shield" traces form power switching nodes, e.g. V_{SWH}, to improve signal integrity
- 4. GL (pin 27) has been connected with GL pad internally and does not need to connect externally

Step 6: Adding Thermal Relief Vias



- Thermal relief vias can be added on the V_{IN} and P_{GND} pads to utilize inner layers for high current and thermal dissipation
- 2. To achieve better thermal performance, additional vias can be put on V_{IN} plane and P_{GND} plane
- 3. V_{SWH} pad is a noise source and not recommended to put vias on this plane
- 4. 8 mil drill for pads and 10 mils drill for plane can be the optional via size. Vias on pad may drain solder during assembly and cause assembly issue. Please consult with the assembly house for guideline

Step 7: Ground Connection



- 1. It is recommended to make single connection between C_{GND} and P_{GND} and this connection can be done on top layer
- 2. It is recommended to make the whole inner 1 layer (next to top layer) ground plane and separate them into C_{GND} and P_{GND} plane
- 3. These ground planes provide shielding between noise source on top layer and signal trace on bottom layer

Multi-Phases VRPower PCB Layout

Following is an example for 6 phase layout. As can be seen, all the VRPower stages are lined in X-direction compactly with decoupling caps next to them. The inductors are placed as close as possible to the SiC632 and SiC632A to minimize the PCB copper loss. Vias are applied on all PADs (V_{IN} , P_{GND} , C_{GND}) of the SiC632 and SiC632A to ensure that both electrical and thermal performance are excellent. Large copper planes are used for all the high current loops, such as V_{IN} , V_{SWH} , V_{OUT} and P_{GND} . These copper planes are duplicated in other layers to minimize the inductance and resistance. All the control signals are routed from the SiC632 and SiC632A to a controller placed to the north of the power stage through inner layers to avoid the overlap of high current loops. This achieves a compact design with the output from the inductors feeding a load located to the south of the design as shown in the figure.

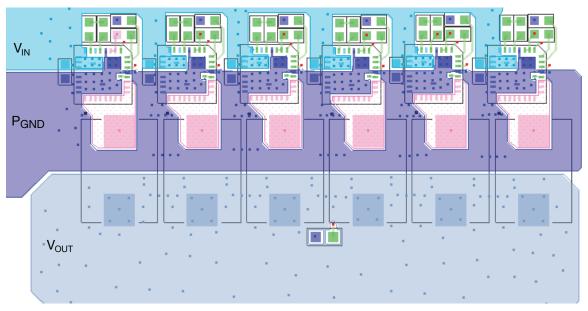


Fig. 24 - Multi - Phase VRPower Layout Top View

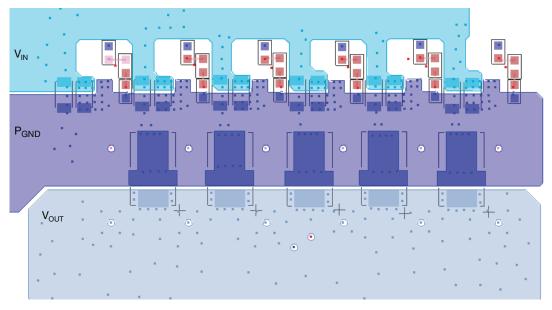


Fig. 25 - Multi - Phase VRPower Layout Bottom View

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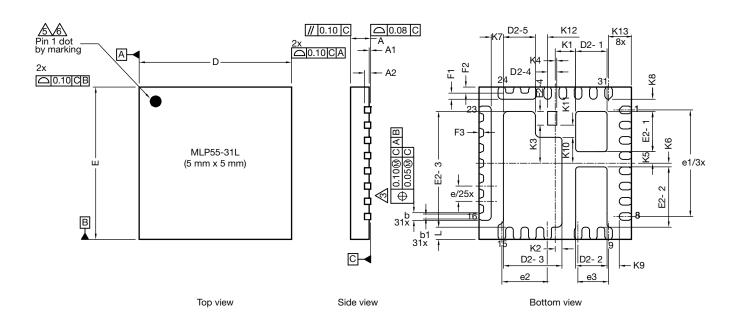
Vishay Siliconix

PRODUCT SUMMARY		
Part number	SiC632	SiC632A
Description	50 A power stage, 4.5 V _{IN} to 24 V _{IN} , 5 V PWM with ZCD mode	50 A power stage, 4.5 $V_{\rm IN}$ to 24 $V_{\rm IN}$, 3.3 V PWM with ZCD mode
Input voltage min. (V)	4.5	4.5
Input voltage max. (V)	24	24
Continuous current rating max. (A)	50	50
Switch frequency max. (kHz)	1500	1500
Enable (yes / no)	Yes	Yes
Monitoring features	-	-
Protection	UVLO, THDN	UVLO, THDN
Light load mode	ZCD	ZCD
Pulse-width modulation (V)	5	3.3
Package type	PowerPAK MLP55-31L	PowerPAK MLP55-31L
Package size (W, L, H) (mm)	5.0 x 5.0 x 0.75	5.0 x 5.0 x 0.75
Status code	2	2
Product type	VRPower (DrMOS)	VRPower (DrMOS)
Applications	Computer, industrial, networking	Computer, industrial, networking

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see www.vishay.com/ppg?62992.



PowerPAK® MLP55-31L Case Outline



DIM.		MILLIMETERS			INCHES		
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.70	0.75	0.80	0.027	0.029	0.031	
A1	0.00	-	0.05	0.000	-	0.002	
A2		0.20 ref.			0.008 ref.		
b	0.20	0.25	0.30	0.078	0.098	0.011	
b1	0.15	0.20	0.25	0.006	0.008	0.010	
D	4.90	5.00	5.10	0.193	0.196	0.200	
е		0.50 BSC			0.019 BSC		
e1		3.50 BSC			0.138 BSC		
e2		1.50 BSC			0.060 BSC		
e3		1.00 BSC 0.040 BSC					
E	4.90	5.00	5.10	0.193	0.196	0.200	
L	0.35	0.40	0.45	0.013	0.015	0.017	
D2-1	0.98	1.03	1.08	0.039	0.041	0.043	
D2-2	0.98	1.03	1.08	0.039	0.041	0.043	
D2-3	1.87	1.92	1.97	0.074	0.076	0.078	
D2-4		0.30 BSC			0.012 BSC		
D2-5	1.05	1.10	1.15	0.041	0.043	0.045	
E2-1	1.27	1.32	1.37	0.050	0.052	0.054	
E2-2	1.93	1.98	2.03	0.076	0.078	0.080	
E2-3	3.75	3.80	3.85	0.148	0.150	0.152	
E2-4		0.45 BSC			0.018 BSC		
F1	0.15	0.20	0.25	0.006	0.008	0.010	
F2		0.20 ref.			0.008 ref.		
F3		0.15 ref.			0.006 ref.		

Revision: 21-Aug-17 1 Document Number: 64909

Package Information

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DIM.	MILLIMETERS			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
K1		0.67 BSC			0.026 BSC	
K2		0.22 BSC			0.008 BSC	
K3		1.25 BSC			0.049 BSC	
K4		0.10 BSC			0.004 BSC	
K5		0.38 BSC			0.015 BSC	
K6	0.12 BSC				0.005 BSC	
K7		0.40 BSC			0.016 BSC	
K8		0.40 BSC			0.016 BSC	
K9		0.40 BSC			0.016 BSC	
K10		0.85 BSC 0.033 BSC				
K11	0.40 BSC 0.016 BSC					
K12	0.40 BSC 0.016 BSC					
K13	0.75 BSC 0.030 BSC					

DWG: 6025

Notes

- 1. Use millimeters as the primary measurement
- 2. Dimensioning and tolerances conform to ASME Y14.5M. 1994

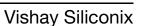
 Δ Dimension b applies to plated terminal and is measured between 0.20 mm and 0.25 mm from terminal tip

🛝 The pin #1 identifier must be existed on the top surface of the package by using indentation mark or other feature of package body

5 Exact shape and size of this feature is optional

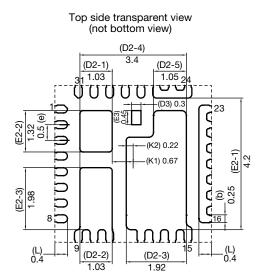
6. Package warpage max. 0.08 mm

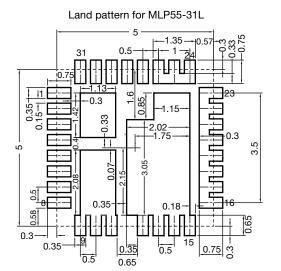
Applied only for terminals



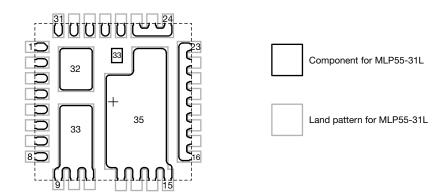


Recommended Land Pattern PowerPAK® MLP55-31L





All dimensions in millimeters



Revision: 18-Oct-2019 1 Document Number: 66944



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